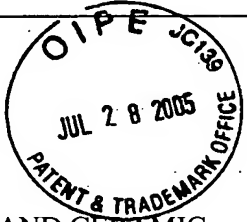


IFW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): OONISHI		Atty. Dkt.: 11-219
Serial No.: 10/765,882		Group Art Unit: 2632
Filed: January 29, 2004		Examiner: Unknown
Title: SENSOR DEVICE AND CERAMIC PACKAGE FOR MOUNTING ELECTRONIC COMPONENTS		

Commissioner for Patents
Alexandria, VA 22314

Date: July 28, 2005

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the references listed on the attached Form PTO-1449 are being brought to the attention of the Examiner without any admission that they constitute statutory prior art, or without any admission that they contain subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

Further, pursuant to 37 C.F.R. §1.97(e), the undersigned hereby certifies that each listed reference was first cited in a Communication (copy enclosed) from a foreign patent office in connection with a counterpart foreign application not more than three months prior to the filing of this statement.

Although no fees are believed to be due at this time, it is respectfully requested that any such fees be charged to Deposit Account 50-1147. Also, the Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed references have been considered and made of record.

Respectfully submitted,



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FORM PTO-1449	ATTY. DKT NO.	11-219	SER. NO.	10/765,882
	APPLICANT	OONISHI		
	FILING DATE	January 29, 2004	GROUP	2632



REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
	5,633,461	02/27/97	Kakizaki et al.		

FOREIGN PATENT DOCUMENTS

								TRANSLATION	
		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO
									Eng. Abstract
		WO 92/20096	11/12/92	PCT				X	
		EP 0 261 555	03/30/88	Europe				X	
		DE 195 03 778	08/08/96	Germany					X

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER		DATE CONSIDERED	